

Square aluminium MOS-capacitors ( $250 \times 250 \mu\text{m}^2$  and  $500 \times 500 \mu\text{m}^2$ ) were fabricated on  $R_S = 48.3 \Omega$  Si wafers and tested. Following SC-1/SC-2 of the bare wafers, a  $454 \pm 5 \text{nm}$ -thick oxide was grown by 1-hour dry oxidation at  $1000^\circ\text{C}$ . About  $2500 \text{\AA}$  of aluminum was deposited<sup>1</sup> via PVD, and the backside oxide was etched. The metal was patterned via  $365 \text{nm}$  lithography, and the final product was sintered for 15 minutes at  $425^\circ\text{C}$ .

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<sup>1</sup>Measured values haven't been posted on Stellar by time of writing